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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/812,150	SMITH ET AL.	
Examiner	Art Unit	
Gopal C. Ray	2111	

	SEARCHED		
Class	Subclass	Date	Examiner
710	311,305,6 2,72,3,8,1 04105,100	11/10/2005	GCR
370	349,392	11/10/2005	GCR
370	466,474	11/10/2005	GCR
370	389,463	11/10/2005	GCR
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709	230	11/10/2005	GCR
711	203	11/10/2005	GCR
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
WEST: US PGPUB, USPT, US OCR, EPO ABS, JPO ABS, DWPI, IBM TDb (see search history printouts)	11/8/2005	GCR
EAST: USPT (see search history printouts)	11/8/2005	GCR
NPL: IEEE Xplore (see search history printouts)	11/8/2005	GCR